

**Notice of References Cited**

Application/Control No.

09/911,069

Applicant(s)/Patent Under  
Reexamination  
PERRY ET AL.

Examiner

John L. Goff

Art Unit

1733

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,270,193	08-2001	Hiwada, Shuhei	347/50
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 09323415 A	12-1997	Japan	HIWADA, SHIYUUHEI	B41J 02/045
	O					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English abstract of JP 09323415
	V	"Worldwide Trends in Flip Chip Developments" Vardaman 1999
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.